

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
214935US2PCTSERIAL NO.
09/926,335

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Hiroyuki FUKADAFILING DATE
October 23, 2001GROUP
2684

U.S. PATENT DOCUMENTS

| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB CLASS | FILING DATE IF APPROPRIATE |
|---------------------|----|--------------------|------------|-----------------|-------|--------------|-------------------------------|
| | AA | 5,751,767 | 05/12/1998 | Tatsumi Satoshi | | | |
| | AB | | | | | | |
| | AC | | | | | | |
| | AD | | | | | | |
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FOREIGN PATENT DOCUMENTS

| | | DOCUMENT NUMBER | DATE | COUNTRY | TRANSLATION YES NO | |
|-------|----|--------------------|------------|---------------------------|-----------------------|--|
| | AO | EP 0884861 A2 | 12/16/1998 | Europe (English Language) | | |
| S. A. | AP | WO 94/18756 A | 08/18/1994 | WIPO (English Language) | | |
| | AQ | | | | | |
| | AR | | | | | |
| | AS | | | | | |
| | AT | | | | | |
| | AU | | | | | |
| | AV | | | | | |

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

| | | |
|--|----|--|
| | AW | |
| | AX | |
| | AY | |
| | AZ | |

☐ Additional References sheet(s) attached

Examiner

Shaima A. Lingrey

Date Considered 5-3-05

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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U.S. PATENT DOCUMENTS

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| | AA | | | | | | |
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FOREIGN PATENT DOCUMENTS

| | | DOCUMENT NUMBER | DATE | COUNTRY | TRANSLATION | |
|------|----|--------------------|------------|--|-------------|----|
| | | | | | YES | NO |
| S.A. | AO | 9-135215 | 05/20/97 | JAPAN (with partial English translation) | | X |
| S.A. | AP | 1 096 711 | 05/02/2001 | EUROPE | | |
| | AQ | | | | | |
| | AR | | | | | |
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| | AZ | |

☐ Additional References sheet(s) attached

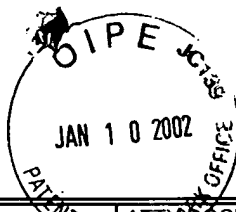
Examiner

Shaina A. Amis

Date Considered

3-2-04

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SHEET 1 OF 1

Form PTO 1449
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FOREIGN PATENT DOCUMENTS

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|------|----|--------------------|------------|--|-----------------------|
| S.A. | AO | WO 2000-02338 | 01/13/2000 | WIPO | |
| | AP | 1225529 | 08/11/99 | CHINA | |
| | AQ | 8-79161 | 03/22/96 | JAPAN (submitting English Abstract only) | |
| | AR | 8-223108 | 08/30/96 | JAPAN (with English Abstract) | X |
| | AS | 9-135215 | 05/20/97 | JAPAN (with English Abstract) | X |
| | AT | 11-220774 | 08/10/99 | JAPAN (with English Abstract) | X |
| S.A. | AU | 2000-22665 | 01/21/2000 | JAPAN (with English Abstract) | X |
| | AV | | | | |

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